

### General Description

The 2060K. uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a wide variety of applications.

### Features

- $V_{DS}=20V$ ;  $I_D=60A$ ;
- $R_{DS(ON)}<6.0m\Omega @ V_{GS}=4.5V$
- $R_{DS(ON)}<8.2m\Omega @ V_{GS}=2.5V$
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

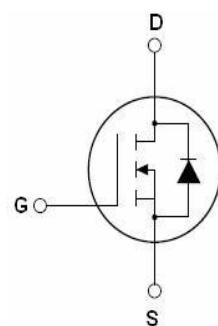
### Application

- Battery Protection
- Load switch
- Power management

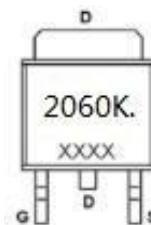
100% UIS TESTED!  
100%  $\Delta V_{ds}$  TESTED!



TO-252(DPAK)  
Top View



Schematic Diagram



Marking and pin Assignment

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
2060K.	2060K.	TO-252	325mm	16mm	2500

Table 1. Absolute Maximum Ratings (TA=25°C)

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0V$ )	20	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0V$ )	$\pm 12$	V
$I_D$	Drain Current-Continuous( $T_c=25^\circ C$ ) <sup>(Note 1)</sup>	60	A
	Drain Current-Continuous( $T_c=100^\circ C$ )	45	A
$I_{DM}$ (pulse)	Drain Current-Continuous@ Current-Pulsed <sup>(Note 2)</sup>	220	A
$P_D$	Maximum Power Dissipation( $T_c=25^\circ C$ )	64	W
	Maximum Power Dissipation( $T_c=100^\circ C$ )	39	W
$E_{AS}$	Avalanche energy <sup>(Note 3)</sup>	256	mJ
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 To 155	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JC}$	Thermal Resistance,Junction-to-Case	-	1.85	°C/W



2060K. (文件编号: S&amp;CIC1874)

## N-Channel Trench Power MOSFET

Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	20			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.45	0.7	1.0	V
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =15A		35		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A(T <sub>c</sub> =25°C)		4.2	6.0	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A (T <sub>c</sub> =125°C)		6.0	10	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =15A		5.2	8.2	mΩ
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1.0MHz		2850		pF
C <sub>oss</sub>	Output Capacitance			365		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			285		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.2		Ω
<b>Switching Times</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω, R <sub>GEN</sub> =3Ω		18		nS
t <sub>r</sub>	Turn-on Rise Time			52		nS
t <sub>d(off)</sub>	Turn-Off Delay Time			76		nS
t <sub>f</sub>	Turn-Off Fall Time			26		nS
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> =4.5V, V <sub>DS</sub> =10V, I <sub>D</sub> =12A		34		nC
Q <sub>gs</sub>	Gate-Source Charge			4		nC
Q <sub>gd</sub>	Gate-Drain Charge			13		nC
<b>Source-Drain Diode Characteristics</b>						
I <sub>SD</sub>	Source-Drain Current(Body Diode)				60	A
V <sub>SD</sub>	Forward on Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =20A			1.2	V
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=100A/μs		24		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=100A/μs		11		nC

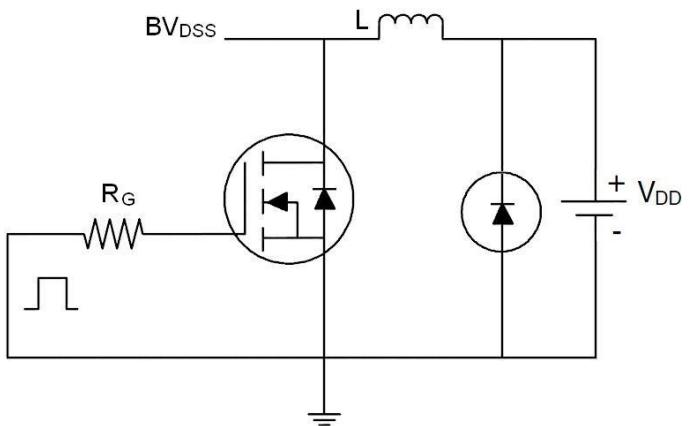
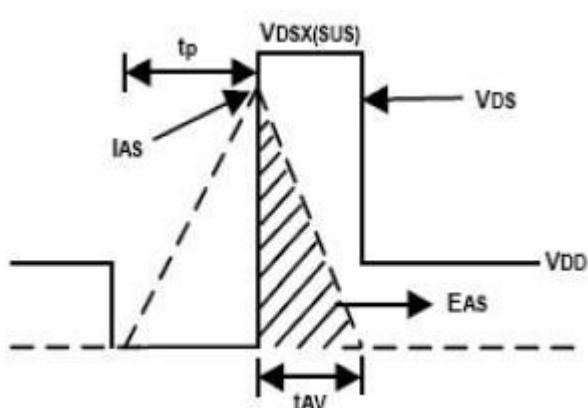
Notes 1.The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

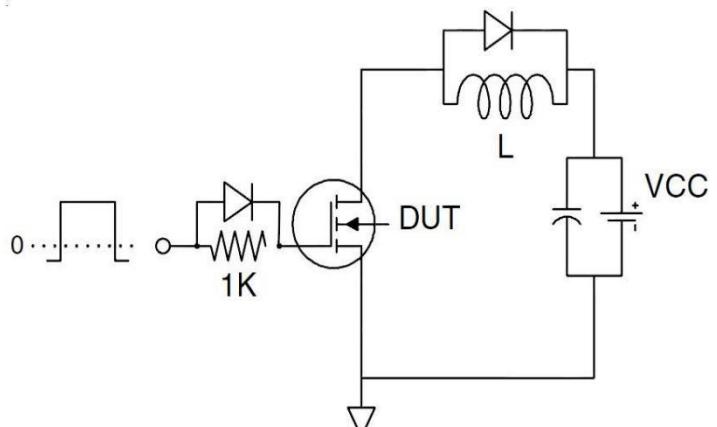
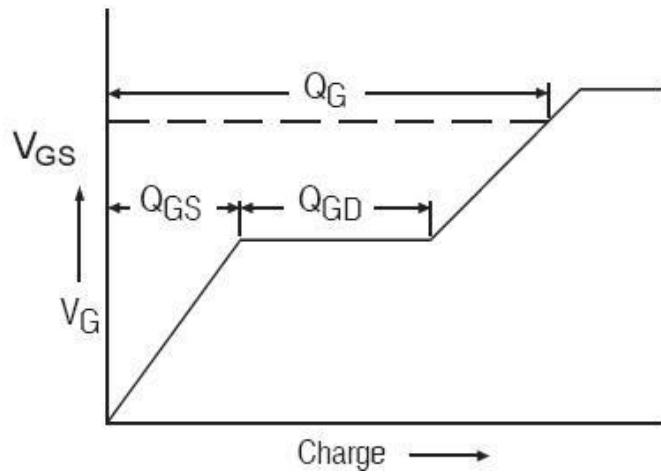
Notes 3.EAS condition: TJ=25°C, VDD=30V, VG=4.5V, RG=25Ω,

## Test Circuit

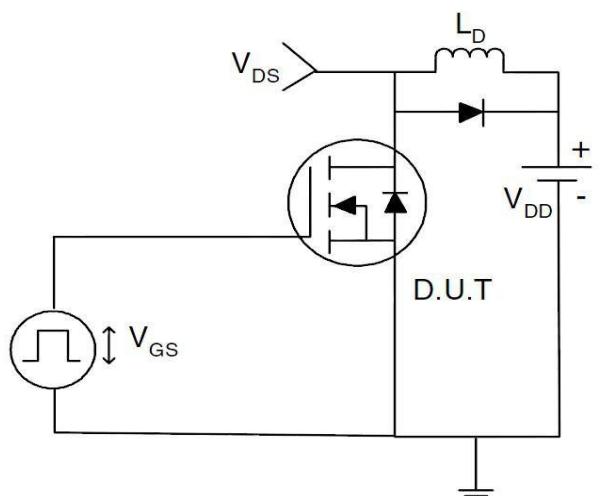
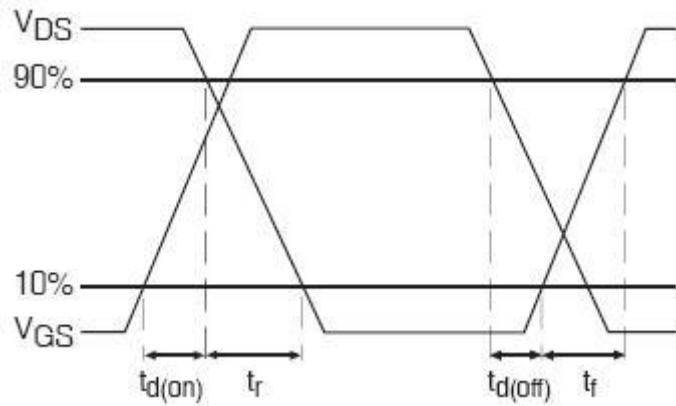
### EAS Test Circuits:



### Gate Charge Test Circuit:



### Switch Time Test Circuit:



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS(Curves)

Figure 1. Output Characteristics

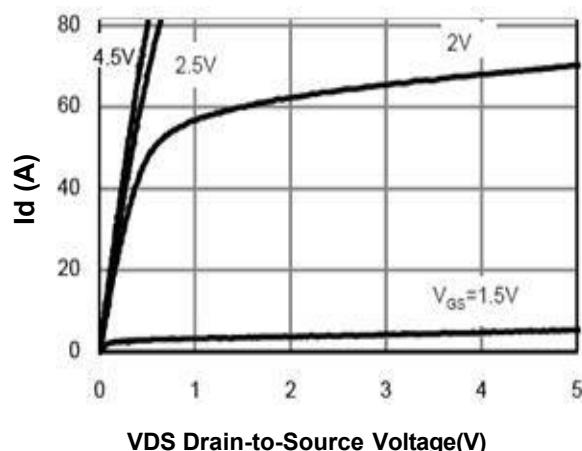


Figure 2. Transfer Characteristics

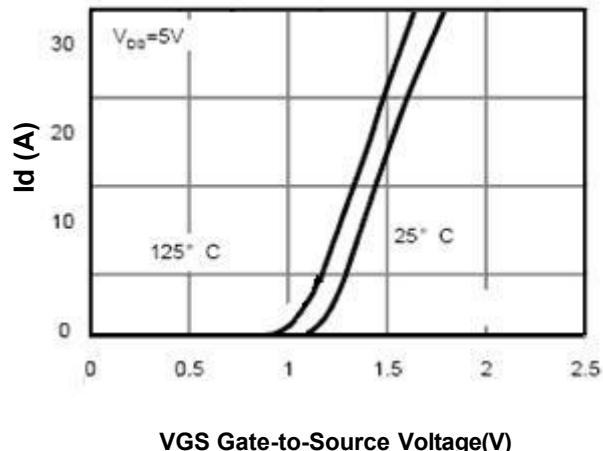


Figure 3. Max  $BV_{DSS}$  vs Junction Temperature

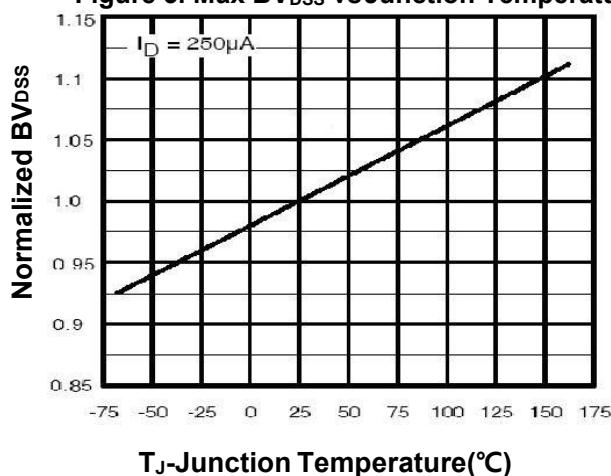


Figure 4. Drain Current

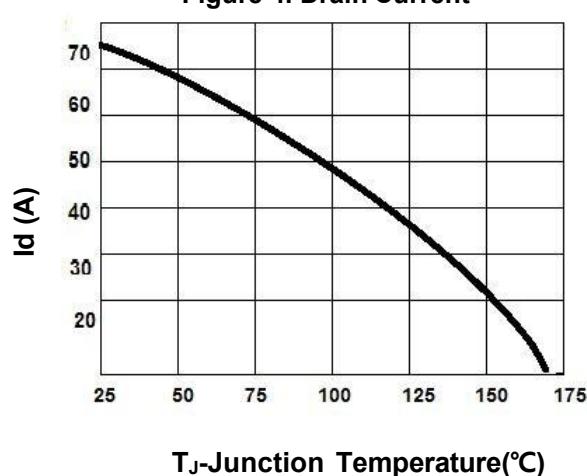


Figure 5.  $V_{GS(th)}$  vs Junction Temperature

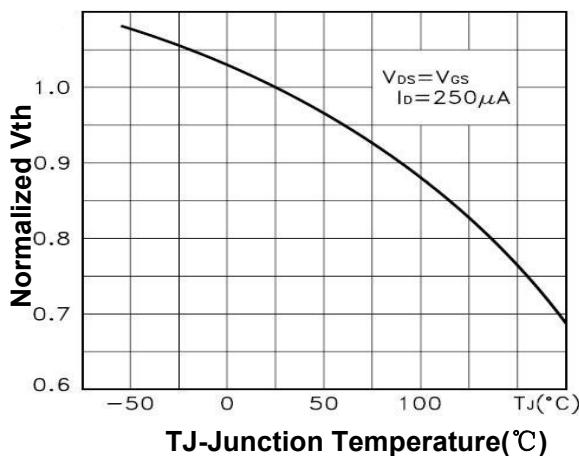


Figure 6.  $R_{DS(ON)}$  vs Junction Temperature

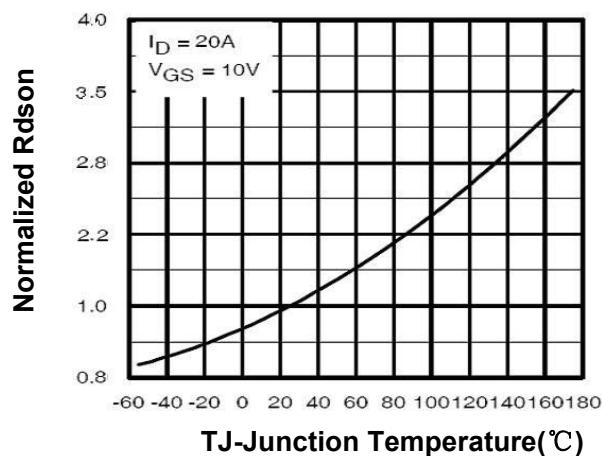


Figure 7. Gate Charge Waveforms

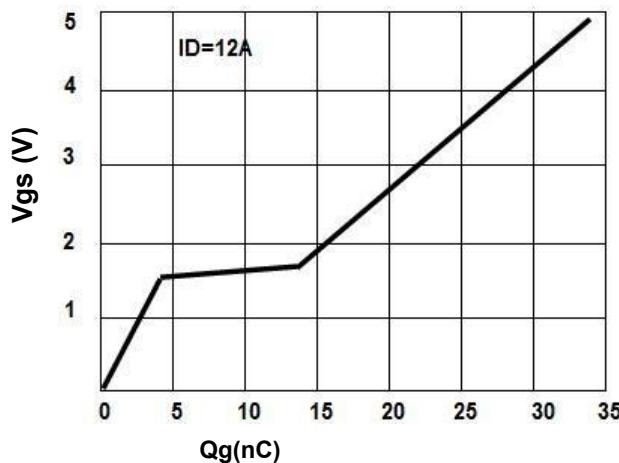


Figure 8. Capacitance

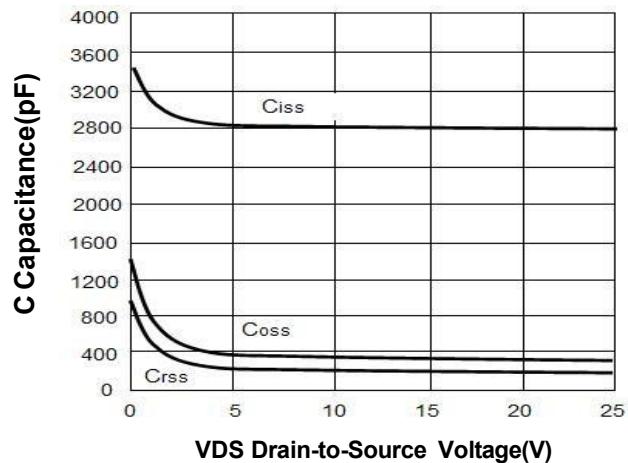


Figure 9. Body-Diode Characteristics

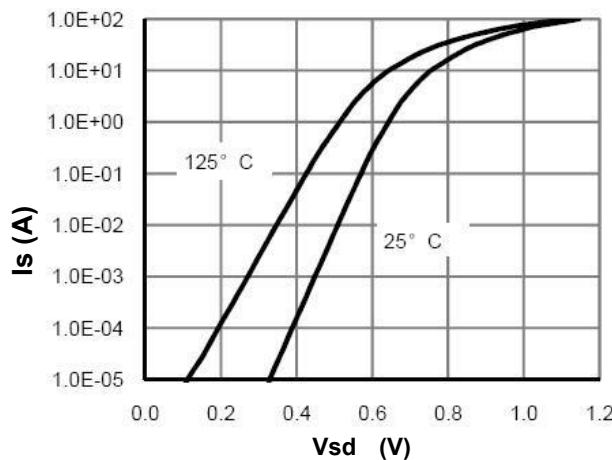


Figure 10. Maximum Safe Operating Area

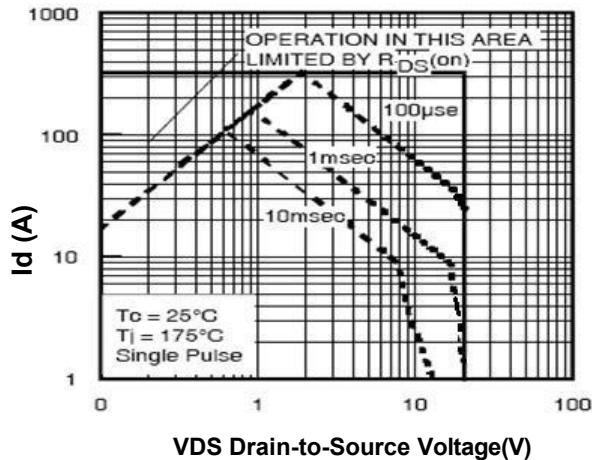
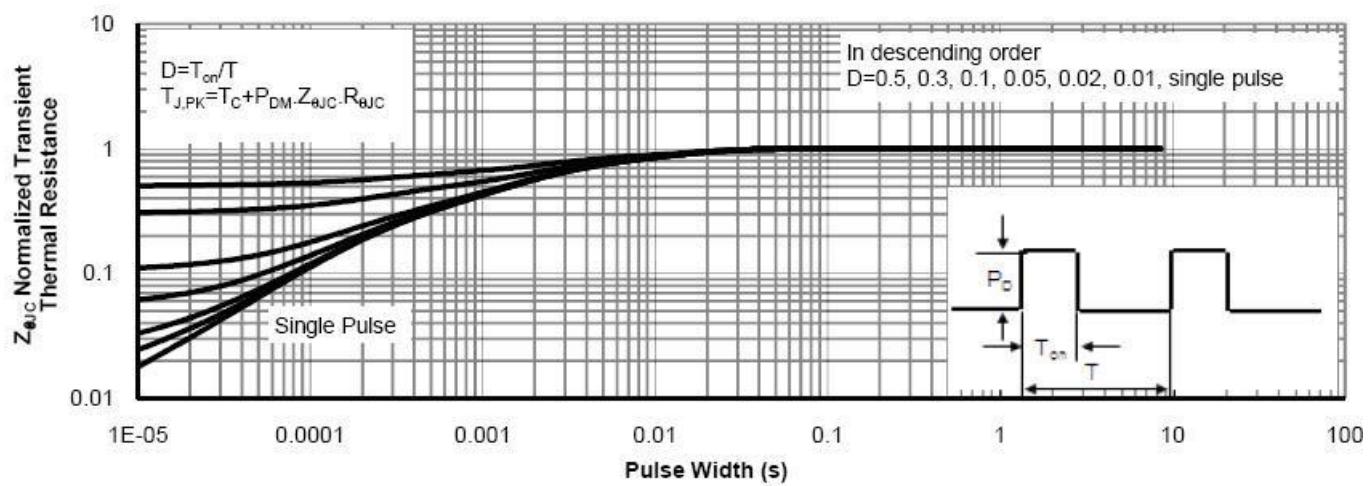
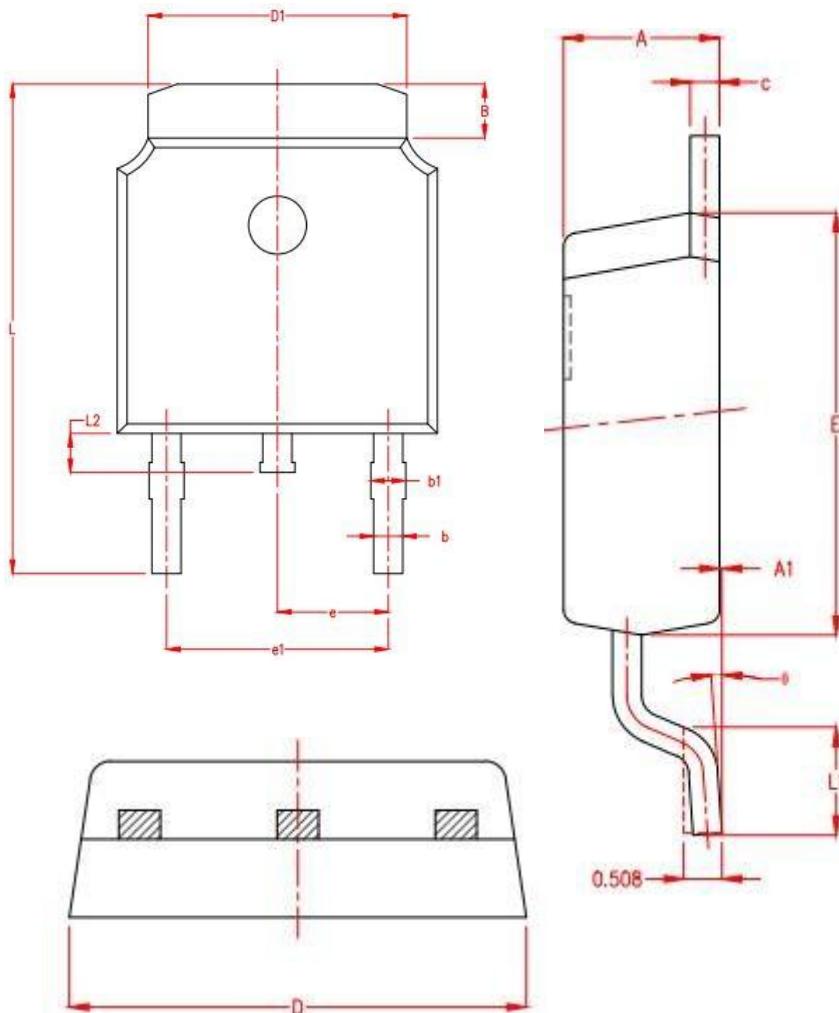


Figure 11. Normalized Maximum Transient Thermal Impedance



## TO-252 Package Information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.15	2.25	2.35
A1	0.00	0.06	0.12
B	0.96	1.11	1.26
b	0.59	0.69	0.79
b1	0.69	0.81	0.93
c	0.34	0.42	0.50
D	6.45	6.60	6.75
D1	5.23	5.33	5.43
E	5.95	6.10	6.25
e	2.286TYP.		
e1	4.47	4.57	4.67
L	9.90	10.10	10.30
L1	1.40	1.55	1.70
L2	0.60	0.80	1.00
θ	0°	4°	8°